

# SN54ABT16657, SN74ABT16657 16-BIT TRANSCEIVERS WITH PARITY GENERATORS/CHECKERS AND 3-STATE OUTPUTS

SCBS103B – FEBRUARY 1992 – REVISED JANUARY 1997

- Members of the Texas Instruments *Widebus™* Family
- State-of-the-Art *EPIC-IIB™* BICMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical  $V_{OLP}$  (Output Ground Bounce) < 1 V at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$
- Distributed  $V_{CC}$  and GND Pin Configuration Minimizes High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- High-Drive Outputs ( $-32\text{-mA } I_{OH}$ ,  $64\text{-mA } I_{OL}$ )
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings

## description

The 'ABT16657 contain two noninverting octal transceiver sections with separate parity generator/checker circuits and control signals. For either section, the transmit/receive ( $1T/\bar{R}$  or  $2T/\bar{R}$ ) input determines the direction of data flow. When  $1T/\bar{R}$  (or  $2T/\bar{R}$ ) is high, data flows from the 1A (or 2A) port to the 1B (or 2B) port (transmit mode); when  $1T/\bar{R}$  (or  $2T/\bar{R}$ ) is low, data flows from the 1B (or 2B) port to the 1A (or 2A) port (receive mode). When the output-enable ( $1\bar{O}\bar{E}$  or  $2\bar{O}\bar{E}$ ) input is high, both the 1A (or 2A) and 1B (or 2B) ports are in the high-impedance state.

Odd or even parity is selected by a logic high or low level, respectively, on the  $1\text{ODD}/\bar{\text{EVEN}}$  (or  $2\text{ODD}/\bar{\text{EVEN}}$ ) input.  $1\text{PARITY}$  (or  $2\text{PARITY}$ ) carries the parity bit value; it is an output from the parity generator/checker in the transmit mode and an input to the parity generator/checker in the receive mode.

In the transmit mode, after the 1A (or 2A) bus is polled to determine the number of high bits,  $1\text{PARITY}$  (or  $2\text{PARITY}$ ) is set to the logic level that maintains the parity sense selected by the level at the  $1\text{ODD}/\bar{\text{EVEN}}$  (or  $2\text{ODD}/\bar{\text{EVEN}}$ ) input. For example, if  $1\text{ODD}/\bar{\text{EVEN}}$  is low (even parity selected) and there are five high bits on the 1A bus, then  $1\text{PARITY}$  is set to the logic high level so that an even number of the nine total bits (eight 1A-bus bits plus parity bit) are high.

SN54ABT16657 . . . WD PACKAGE  
SN74ABT16657 . . . DGG OR DL PACKAGE  
(TOP VIEW)

$1\bar{O}\bar{E}$	1	56	$1T/\bar{R}$
NC	2	55	$1\text{ODD}/\bar{\text{EVEN}}$
$1\bar{\text{ERR}}$	3	54	$1\text{PARITY}$
GND	4	53	GND
1A1	5	52	1B1
1A2	6	51	1B2
$V_{CC}$	7	50	$V_{CC}$
1A3	8	49	1B3
1A4	9	48	1B4
1A5	10	47	1B5
GND	11	46	GND
1A6	12	45	1B6
1A7	13	44	1B7
1A8	14	43	1B8
2A1	15	42	2B1
2A2	16	41	2B2
2A3	17	40	2B3
GND	18	39	GND
2A4	19	38	2B4
2A5	20	37	2B5
2A6	21	36	2B6
$V_{CC}$	22	35	$V_{CC}$
2A7	23	34	2B7
2A8	24	33	2B8
GND	25	32	GND
$2\bar{\text{ERR}}$	26	31	$2\text{PARITY}$
NC	27	30	$2\text{ODD}/\bar{\text{EVEN}}$
$2\bar{O}\bar{E}$	28	29	$2T/\bar{R}$

NC – No internal connection

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**description (continued)**

In the receive mode, after the 1B (or 2B) bus is polled to determine the number of high bits, the  $\overline{1ERR}$  (or  $\overline{2ERR}$ ) output logic level indicates whether or not the data to be received exhibits the correct parity sense. For example, if  $\overline{1ODD/EVEN}$  is high (odd parity selected),  $\overline{1PARITY}$  is high, and there are three high bits on the 1B bus, then  $\overline{1ERR}$  is low, indicating a parity error.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT16657 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74ABT16657 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

**FUNCTION TABLE**  
 (each 8-bit section)

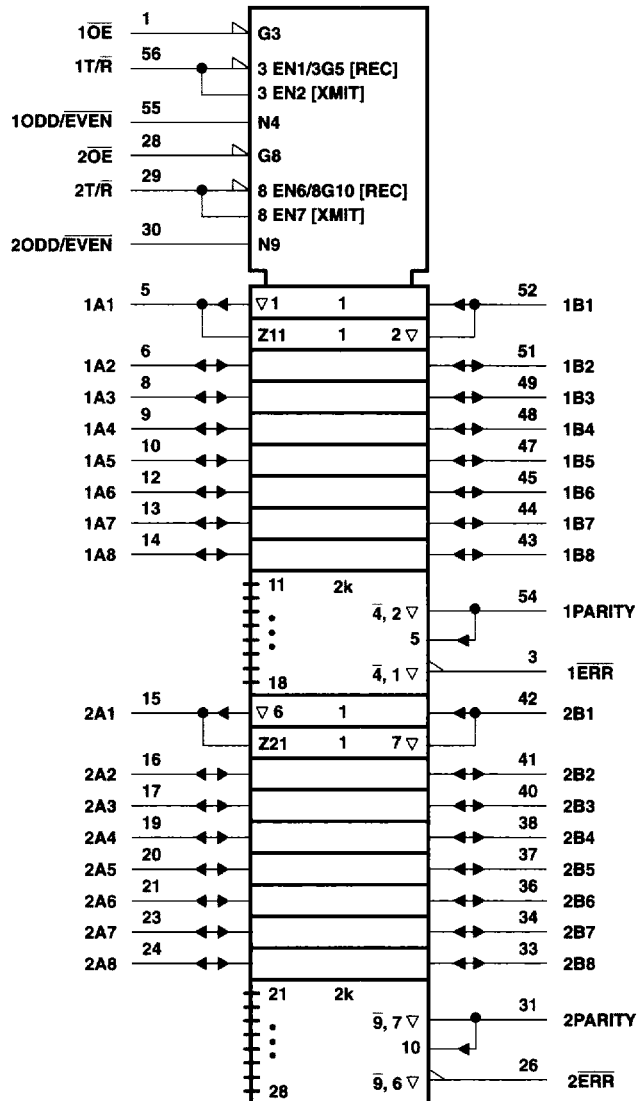
NUMBER OF A OR B INPUTS THAT ARE HIGH	INPUTS			INPUT/OUTPUT PARITY	OUTPUTS	
	$\overline{OE}$	T/R	$\overline{ODD/EVEN}$		$\overline{ERR}$	OUTPUT MODE
0, 2, 4, 6, 8	L	H	H	H	Z	Transmit
	L	H	L	L	Z	Transmit
	L	L	H	H	H	Receive
	L	L	H	L	L	Receive
	L	L	L	H	L	Receive
	L	L	L	L	H	Receive
1, 3, 5, 7	L	H	H	L	Z	Transmit
	L	H	L	H	Z	Transmit
	L	L	H	H	L	Receive
	L	L	H	L	H	Receive
	L	L	L	H	H	Receive
	L	L	L	L	L	Receive
Don't care	H	X	X	Z	Z	Z

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logic symbol†

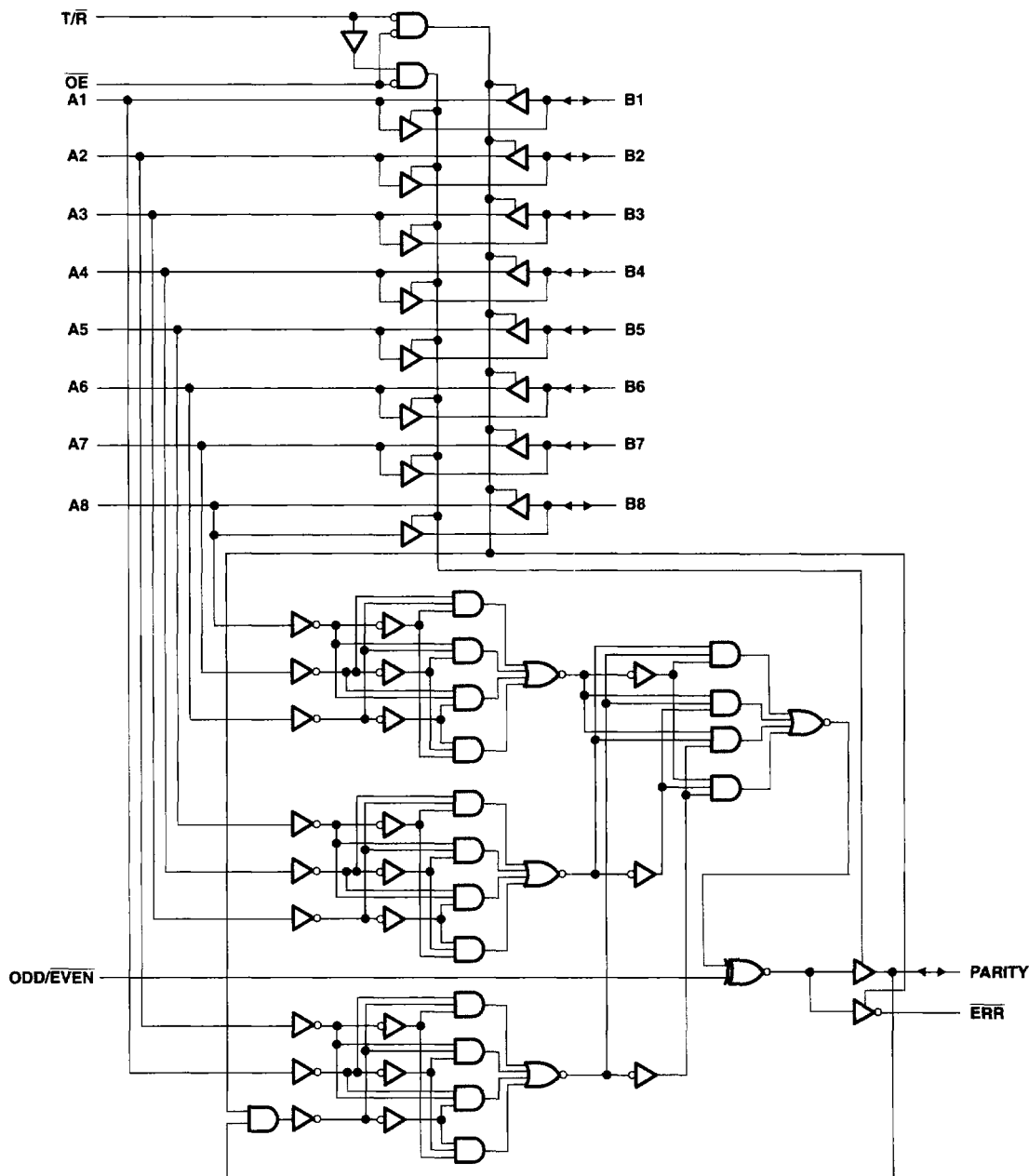


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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**logic diagram (positive logic)**



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, $V_{CC}$ .....	–0.5 V to 7 V
Input voltage range, $V_I$ (except I/O ports) (see Note 1) .....	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, $V_O$ .....	–0.5 V to 5.5 V
Current into any output in the low state, $I_O$ : SN54ABT16657 .....	96 mA
SN74ABT16657 .....	128 mA
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	–18 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	–50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): DGG package .....	81°C/W
DL package .....	74°C/W
Storage temperature range, $T_{stg}$ .....	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

## recommended operating conditions (see Note 3)

		SN54ABT16657		SN74ABT16657		UNIT
		MIN	MAX	MIN	MAX	
$V_{CC}$	Supply voltage	4.5	5.5	4.5	5.5	V
$V_{IH}$	High-level input voltage	2		2		V
$V_{IL}$	Low-level input voltage		0.8		0.8	V
$V_I$	Input voltage	0	$V_{CC}$	0	$V_{CC}$	V
$I_{OH}$	High-level output current		–24		–32	mA
$I_{OL}$	Low-level output current		48		64	mA
$\Delta V/\Delta v$	Input transition rise or fall rate	Outputs enabled		10	10	ns/V
$T_A$	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T <sub>A</sub> = 25°C			SN54ABT16657		SN74ABT16657		UNIT	
		MIN	TYP†	MAX	MIN	MAX	MIN	MAX		
V <sub>IK</sub>	V <sub>CC</sub> = 4.5 V, I <sub>I</sub> = -18 mA			-1.2		-1.2		-1.2	V	
V <sub>OH</sub>	V <sub>CC</sub> = 4.5 V, I <sub>OH</sub> = -3 mA		2.5		2.5		2.5		V	
	V <sub>CC</sub> = 5 V, I <sub>OH</sub> = -3 mA		3		3		3			
	V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -24 mA		2		2				
I <sub>OH</sub> = -32 mA			2*				2			
V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 24 mA		0.55		0.55			V	
		I <sub>OL</sub> = 64 mA		0.55*			0.55			
V <sub>hys</sub>			100						mV	
I <sub>I</sub>	Control inputs A or B ports	V <sub>CC</sub> = 5.5 V, V <sub>I</sub> = V <sub>CC</sub> or GND		±1		±1		±1	μA	
				±100		±100		±100		
I <sub>OZH</sub> ‡	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 2.7 V		50		50		50	μA		
I <sub>OZL</sub> ‡	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 0.5 V		-50		-50		-50	μA		
I <sub>off</sub>	V <sub>CC</sub> = 0, V <sub>I</sub> or V <sub>O</sub> ≤ 4.5 V		±100		±450		±100	μA		
I <sub>CEX</sub>	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 5.5 V	Outputs high		50		50		50	μA	
I <sub>O</sub> §	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 2.5 V		-50 -100 -180		-50 -180		-50 -180		mA	
I <sub>CC</sub>	A or B ports	V <sub>CC</sub> = 5.5 V, I <sub>O</sub> = 0, V <sub>I</sub> = V <sub>CC</sub> or GND	Outputs high		2		2		2	mA
			Outputs low		36		36		36	
			Outputs disabled		2		2		2	
ΔI <sub>CC</sub> ¶	V <sub>CC</sub> = 5.5 V, One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND			50		50		50	μA	
C <sub>I</sub>	Control inputs	V <sub>I</sub> = 2.5 V or 0.5 V		3					pF	
C <sub>I0</sub>	A or B ports	V <sub>O</sub> = 2.5 V or 0.5 V		9					pF	

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

† All typical values are at V<sub>CC</sub> = 5 V.

‡ The parameters I<sub>OZH</sub> and I<sub>OZL</sub> include the input leakage current.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

¶ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50$  pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5$ V, $T_A = 25^\circ$ C			SN54ABT16657		SN74ABT16657		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
$t_{PLH}$	A or B	B or A	1.5	2.5	3.3	1.5	4.2	1.5	4.1	ns
$t_{PHL}$			2	3.1	3.9	2	4.5	2	4.3	
$t_{PLH}$	A	PARITY	2	4.6	5.4	2	7	2	6.7	ns
$t_{PHL}$			2	4.3	5.1	2	6.5	2	6.1	
$t_{PLH}$	ODD/EVEN	PARITY, $\overline{ERR}$	2	4.6	5.4	2	7	2	6.7	ns
$t_{PHL}$			2	4.3	5.1	2	6.5	2	6.1	
$t_{PLH}$	B	$\overline{ERR}$	2	4.6	5.4	2	7	2	6.7	ns
$t_{PHL}$			2	4.3	5.1	2	6.5	2	6.1	
$t_{PLH}$	PARITY	$\overline{ERR}$	2	4.6	5.4	2	7	2	6.7	ns
$t_{PHL}$			2	4.3	5.1	2	6.5	2	6.1	
$t_{PZH}$	$\overline{OE}$	A or B	2	3.9	4.9	2	5.8	2	5.6	ns
$t_{PZL}$			2.5	4.3	5.1	2.5	6.2	2.5	6	
$t_{PHZ}$	$\overline{OE}$	A or B	2	3.6	4.5	2	5.5	2	5.4	ns
$t_{PLZ}$			1.5	3	3.8	1.5	4.7	1.5	4.3	
$t_{PZH}$	$\overline{OE}$	PARITY, $\overline{ERR}$	2	4	4.9	2	5.8	2	5.6	ns
$t_{PZL}$			2.5	4.1	5.1	2.5	6.2	2.5	6	
$t_{PHZ}$	$\overline{OE}$	PARITY, $\overline{ERR}$	1	3.5	4.5	1	5.5	1	5.4	ns
$t_{PLZ}$			1.5	3	3.8	1.5	4.7	1.5	4.3	

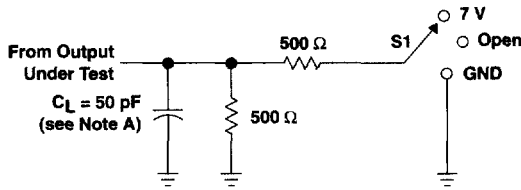
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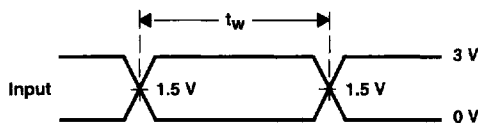
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**PARAMETER MEASUREMENT INFORMATION**

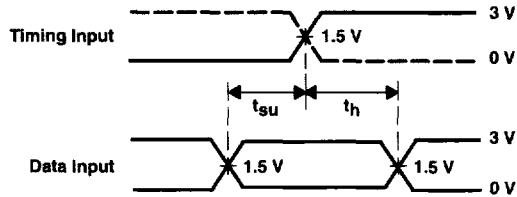


TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	7 V
$t_{PHZ}/t_{PZH}$	Open

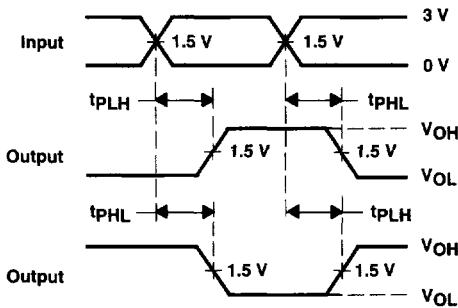
**LOAD CIRCUIT**



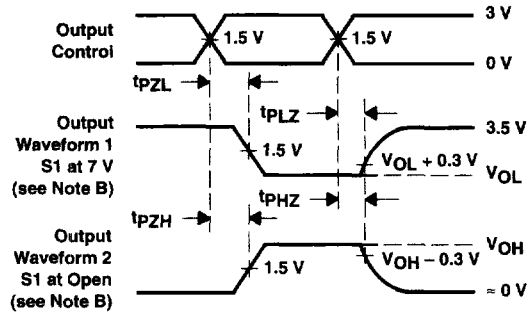
**VOLTAGE WAVEFORMS**  
**PULSE DURATION**



**VOLTAGE WAVEFORMS**  
**SETUP AND HOLD TIMES**



**VOLTAGE WAVEFORMS**  
**PROPAGATION DELAY TIMES**  
**INVERTING AND NONINVERTING OUTPUTS**



**VOLTAGE WAVEFORMS**  
**ENABLE AND DISABLE TIMES**  
**LOW- AND HIGH-LEVEL ENABLING**

- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
 C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10$  MHz,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5$  ns,  $t_f \leq 2.5$  ns.  
 D. The outputs are measured one at a time with one transition per measurement.

**Figure 1. Load Circuit and Voltage Waveforms**